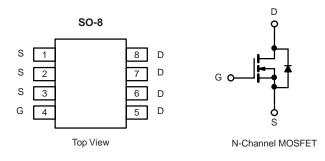


# N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (Typ.)			
60	0.012 at V <sub>GS</sub> = 10 V	12	10.5 nC			
00	0.015 at V <sub>GS</sub> = 4.5 V	11	10.5 HC			



#### **FEATURES**

- Halogen-free According to IEC 61249-2-21
  Definition
- TrenchFET<sup>®</sup> Power MOSFET
- Optimized for "Low Side" Synchronous Rectifier Operation
- 100 % R<sub>g</sub> and UIS Tested

## APPLICATIONS

CCFL Inverter

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
	T <sub>C</sub> = 25 °C		12 <sup>a</sup>	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C		11	
Continuous Drain Current (1) = 150°C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	8.0 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		7.6 <sup>b, c</sup>	A
Pulsed Drain Current	I <sub>DM</sub> 25		A	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	L.	4.2	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	Is	2.1 <sup>b, c</sup>	
Avalanche Current		I <sub>AS</sub>	15	
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	11.2	mJ
	T <sub>C</sub> = 25 °C		5	
Mauinum Dauran Diasinatian	T <sub>C</sub> = 70 °C	р	3.2	14/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.5 <sup>b, c</sup>	W
	T <sub>A</sub> = 70 °C		1.6 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	38	50	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	20	25	C/W	

Notes:

a. Package limited.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 85 °C/W.

COMPLIANT

HALOGEN

Available



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_{D} = 250 \mu A$	60			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 250 1		55		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 6.3			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	1.0		3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zana Oata Maltana Daria Orana d	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μA	
Zero Gate Voltage Drain Current		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	25			A	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.6 A	0.012			_	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 4.2 A		0.015		Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 4.6 A		20		S	
Dynamic <sup>b</sup>	•						
Input Capacitance	C <sub>iss</sub>			1100		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		90			
Reverse Transfer Capacitance	C <sub>rss</sub>			55			
Total Gate Charge		$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 4.6 \text{ A}$		21	32		
	Qg			10.5	16	nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 30$ V, $V_{GS} = 4.5$ V, $I_{D} = 4.6$ A		3.5			
Gate-Drain Charge	Q <sub>gd</sub>			4.2			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		3.3	5	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			20	30		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 30 V, $R_L$ = 5.4 $\Omega$		150	225		
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong 5.6 \text{ A}, \text{ V}_{\text{GEN}}$ = 4.5 V, $R_g$ = 1 $\Omega$		20	30		
Fall Time	t <sub>f</sub>			60	90		
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 30 V, $R_L$ = 5.4 $\Omega$		15	25	-	
Turn-Off DelayTime	t <sub>d(off)</sub>	${\sf I}_{\sf D}\cong$ 5.6 A, ${\sf V}_{\sf GEN}$ = 10 V, ${\sf R}_{\sf g}$ = 1 $\Omega$		25	40		
Fall Time	t <sub>f</sub>			10	15		
Drain-Source Body Diode Characterist	ics						
Continous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			4.2	•	
Pulse Diode Forward Currenta	I <sub>SM</sub>				25	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 2 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	-		25	50	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			25	50	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = 5.5 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		19		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			6			

Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

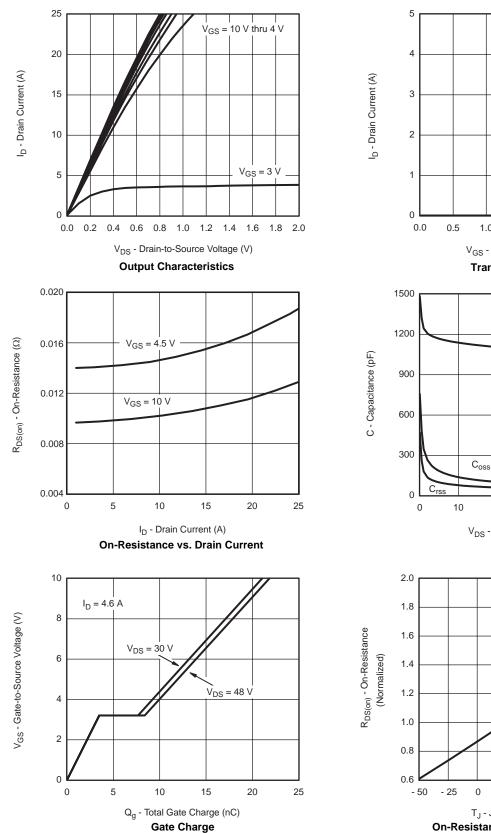
b. Guaranteed by design, not subject to production testing.

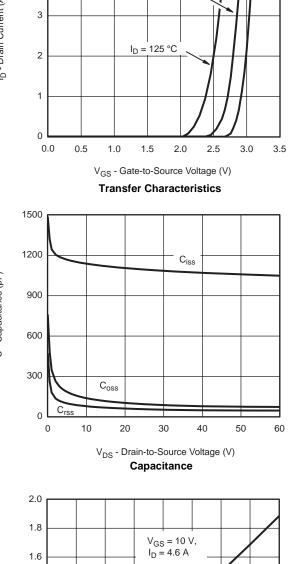
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

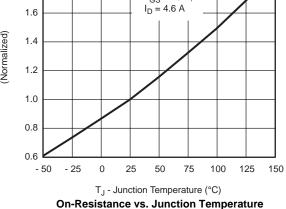


 $T_{\rm C} = -55$ 

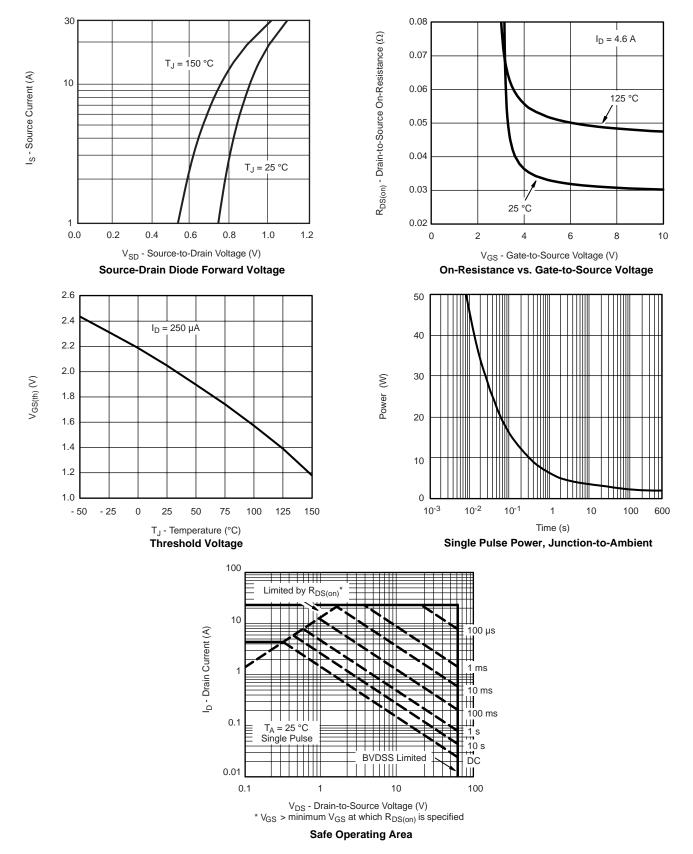
I<sub>D</sub> = 25 °C



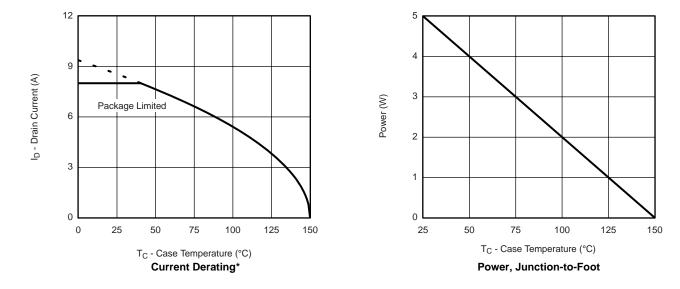






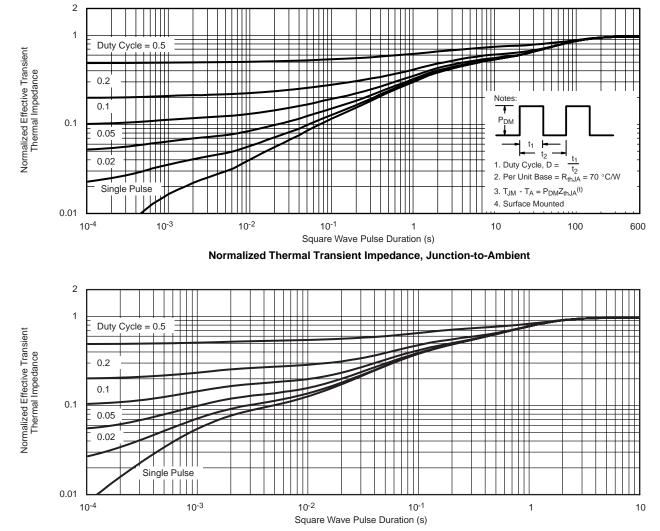






\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Foot



# SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

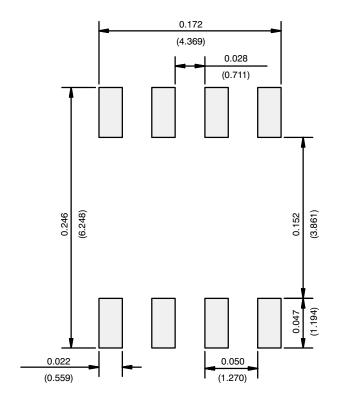




	MILLIMETERS		INC	HES	
DIM	Min	Max	Min	Max	
A	1.35	1.75	0.053	0.069	
A <sub>1</sub>	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



**RECOMMENDED MINIMUM PADS FOR SO-8** 



Recommended Minimum Pads Dimensions in Inches/(mm)



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